muRata

Reference Specification

Metal Terminal Type Multilayer Ceramic Capacitors for General Purpose (KRM21 Series [Temp. Char.: X5R / Rat. Vol.: DC16V, DC25V])

Product specifications in this catalog are as of Dec.2017, and are subject to change or obsolescence without notice.

Please consult the approval sheet before ordering. Please read rating and Cautions first.

▲ Caution

Storage and Operation Conditions

- 1. The performance of chip monolithic ceramic capacitors may be affected by the storage conditions.
 - 1-1. Store the capacitors in the following conditions: Room Temperature of +5°C to +40°C and a Relative Humidity of 20% to 70%.
 - (1) Sunlight, dust, rapid temperature changes, corrosive gas atmosphere, or high temperature and humidity conditions during storage may affect solderability and packaging performance. Therefore, please maintain the storage temperature and humidity. Use the product within six months, as prolonged storage may cause oxidation of the electrodes.
 - (2) Please confirm solderability before using after six months. Store the capacitors without opening the original bag. Even if the storage period is short, do not exceed the specified atmospheric conditions.
 - 1-2. Corrosive gas can react with the termination(external) electrodes or lead wires of capacitors, and result in poor solderability. Do not store the capacitors in an atmosphere consisting of corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas, etc.).
- 1-3. Due to moisture condensation caused by rapid humidity changes, or the photochemical change caused by direct sunlight on the terminal electrodes and/or the resin/epoxy coatings, the solderability and electrical performance may deteriorate. Do not store capacitors under direct sunlight or in high humidity conditions.

Rating

1. Temperature Dependent Characteristics

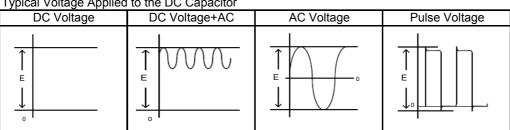
- 1. The electrical characteristics of a capacitor can change with temperature.
 - 1-1. For capacitors having larger temperature dependency, the capacitance may change with temperature changes. The following actions are recommended in order to ensure suitable capacitance values.
 - (1) Select a suitable capacitance for the operating temperature range.
 - (2) The capacitance may change within the rated temperature. When you use a high dielectric constant type capacitor in a circuit that needs a tight (narrow) capacitance tolerance (e.g., a time-constant circuit), please carefully consider the temperature characteristics, and carefully confirm the various characteristics in actual use conditions and the actual system.

2. Measurement of Capacitance

- 1. Measure capacitance with the voltage and frequency specified in the product specifications.
- 1-1. The output voltage of the measuring equipment may decrease occasionally when capacitance is high. Please confirm whether a prescribed measured voltage is impressed to the capacitor.
- 1-2. The capacitance values of high dielectric constant type capacitors change depending on the AC voltage applied. Please consider the AC voltage characteristics when selecting a capacitor to be used in an AC circuit.

3. Applied Voltage

- 1. Do not apply a voltage to the capacitor that exceeds the rated voltage as called out in the specifications.
- 1-1. Applied voltage between the terminals of a capacitor shall be less than or equal to the rated voltage.
 - (1) When AC voltage is superimposed on DC voltage, the zero-to-peak voltage shall not exceed the rated DC voltage. When AC voltage or pulse voltage is applied, the peak-to-peak voltage shall not exceed the rated DC voltage.
 - (2) Abnormal voltages (surge voltage, static electricity, pulse voltage, etc.) shall not exceed the rated DC voltage.



Typical Voltage Applied to the DC Capacitor

(E: Maximum possible applied voltage.)

1-2. Influence of over voltage

Over voltage that is applied to the capacitor may result in an electrical short circuit caused by the breakdown of the internal dielectric layers. The time duration until breakdown depends on the applied voltage and the ambient temperature.

2. Use a safety standard certified capacitor in a power supply input circuit (AC filter), as it is also necessary to consider the withstand voltage and impulse withstand voltage defined for each device.

4. Type of Applied Voltage and Self-heating Temperature

- Confirm the operating conditions to make sure that no large current is flowing into the capacitor due to the continuous application of an AC voltage or pulse voltage. When a DC rated voltage product is used in an AC voltage circuit or a pulse voltage circuit, the AC current or pulse current will flow into the capacitor; therefore check the self-heating condition. Please confirm the surface temperature of the capacitor so that the temperature remains within the upper limits of the operating temperature, including the rise in temperature due to self-heating. When the capacitor is used with a high-frequency voltage or pulse voltage, heat may be generated by dielectric loss.
 <Applicable to Rated Voltage of less than DC100V>
 - 1-1. The load should be contained to the level such that when measuring at atmospheric temperature of 25°C, the product's self-heating remains below 20°C and the surface temperature of the capacitor in the actual circuit remains within the maximum operating temperature.

<Applicable to Temperature Characteristic X7R, X7T beyond Rated Voltage of DC200V>

1-2. The load should be contained so that the self-heating of the capacitor body remains below 20°C, when measuring at an ambient temperature of 25°C. In addition, use a K thermocouple of φ0.1mm with less heat capacity when measuring, and measure in a condition where there is no effect from the radiant heat of other components or air flow caused by convection. Excessive generation of heat may cause deterioration of the characteristics and reliability of the capacitor. (Absolutely do not perform measurements while the cooling fan is operating, as an accurate measurement may not be performed.)

5. DC Voltage and AC Voltage Characteristics

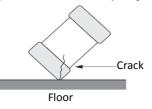
- 1. The capacitance value of a high dielectric constant type capacitor changes depending on the DC voltage applied. Please consider the DC voltage characteristics when a capacitor is selected for use in a DC circuit.
 - 1-1. The capacitance of ceramic capacitors may change sharply depending on the applied voltage (see figure).
 - Please confirm the following in order to secure the capacitance.
 - (1) Determine whether the capacitance change caused by the applied voltage is within the allowed range.
 - (2) In the DC voltage characteristics, the rate of capacitance change becomes larger as voltage increases, even if the applied voltage is below the rated voltage. When a high dielectric constant type capacitor is used in a circuit that requires a tight (narrow) capacitance tolerance (e.g., a time constant circuit), please carefully consider the voltage characteristics, and confirm the various characteristics in actual operating conditions in an actual system.
- 2. The capacitance values of high dielectric constant type capacitors changes depending on the AC voltage applied. Please consider the AC voltage characteristics when selecting a capacitor to be used in an AC circuit.

6. Capacitance Aging

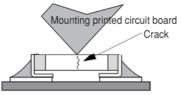
1. The high dielectric constant type capacitors have the characteristic in which the capacitance value decreases with the passage of time. When you use high dielectric constant type capacitors in a circuit that needs a tight (narrow) capacitance tolerance (e.g., a time-constant circuit), please carefully consider the characteristics of these capacitors, such as their aging, voltage, and temperature characteristics. In addition, check capacitors using your actual appliances at the intended environment and operating conditions.

7. Vibration and Shock

- 1. Please confirm the kind of vibration and/or shock, its condition, and any generation of resonance. Please mount the capacitor so as not to generate resonance, and do not allow any impact on the terminals.
- 2. Mechanical shock due to being dropped may cause damage or a crack in the dielectric material of the capacitor. Do not use a dropped capacitor because the quality and reliability may be deteriorated.



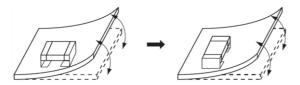
3. When printed circuit boards are piled up or handled, the corner of another printed circuit board should not be allowed to hit the capacitor, in order to avoid a crack or other damage to the capacitor.



Soldering and Mounting

1. Mounting Position

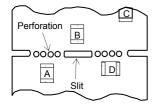
- 1. Confirm the best mounting position and direction that minimizes the stress imposed on the capacitor during flexing or bending the printed circuit board.
- 1-1. Choose a mounting position that minimizes the stress imposed on the chip during flexing or bending of the board. [Component Direction]



Locate chip horizontal to the direction in which stress acts.

[Chip Mounting Close to Board Separation Point]

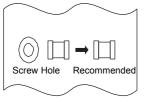
It is effective to implement the following measures, to reduce stress in separating the board. It is best to implement all of the following three measures; however, implement as many measures as possible to reduce stress.



Contents of Measures	Stress Level
 Turn the mounting direction of the component parallel to the board separation surface. 	A>D
(2) Add slits in the board separation part.	A>B
(3) Keep the mounting position of the component away from the board separation surface.	A>C

[Mounting Capacitors Near Screw Holes]

When a capacitor is mounted near a screw hole, it may be affected by the board deflection that occurs during the tightening of the screw. Mount the capacitor in a position as far away from the screw holes as possible.



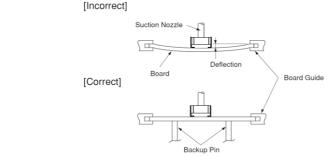
2. Information before Mounting

- 1. Do not re-use capacitors that were removed from the equipment.
- 2. Confirm capacitance characteristics under actual applied voltage.
- 3. Confirm the mechanical stress under actual process and equipment use.
- 4. Confirm the rated capacitance, rated voltage and other electrical characteristics before assembly.
- 5. Prior to use, confirm the solderability of capacitors that were in long-term storage.
- 6. Prior to measuring capacitance, carry out a heat treatment for capacitors that were in long-term storage.
- 7. The use of Sn-Zn based solder will deteriorate the reliability of the MLCC. Please contact our sales representative or product engineers on the use of Sn-Zn based solder in advance.
- 8. We have also produced a DVD which shows a summary of our opinions, regarding the precautions for mounting. Please contact our sales representative to request the DVD.

3. Maintenance of the Mounting (pick and place) Machine

1. Make sure that the following excessive forces are not applied to the capacitors.

- 1-1. In mounting the capacitors on the printed circuit board, any bending force against them shall be kept to a minimum to prevent them from any bending damage or cracking. Please take into account the following precautions and recommendations for use in your process.
 - (1) Adjust the lowest position of the pickup nozzle so as not to bend the printed circuit board.
 - (2) Adjust the nozzle pressure within a static load of 1N to 3N during mounting.



▲ Caution

2. Dirt particles and dust accumulated between the suction nozzle and the cylinder inner wall prevent the nozzle from moving moving smoothly. This imposes greater force upon the chip during mounting, causing cracked chips. Also, the locating claw, when worn out, imposes uneven forces on the chip when positioning, causing cracked chips. The suction nozzle and the locating claw must be maintained, checked, and replaced periodically.

4-1. Reflow Soldering

- 1. When sudden heat is applied to the components, the mechanical strength of the components will decrease because a sudden temperature change causes deformation inside the components. In order to prevent mechanical damage to the components, preheating is required for both the components and the PCB. Preheating conditions are shown in table 1. It is required to keep the temperature differential between the solder and the components surface (Δ T) as small as possible.
- Solderability of tin plating termination chips might be deteriorated when a low temperature soldering profile where the peak solder temperature is below the melting point of tin is used. Please confirm the solderability of tin plated termination chips before use.
- 3. When components are immersed in solvent after mounting, be sure to maintain the temperature difference (Δ T) between the component and the solvent within the range shown in table 1.

Table 1

Part Number	Temperature Differential
K🗆 🗆 21 / K🗆 🗆 31	ΔT≦190°C
K□□55	ΔT≦130°C

Recommended Conditions

		Lead Free Solder	
	Reflow Vapor Reflow		
Peak Temperature	230 to 250°C	230 to 240°C	240 to 260°C
Atmosphere	Air	Saturated vapor of inactive solvent	Air or N2

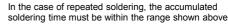
Pb-Sn Solder: Sn-37Pb

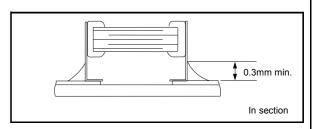
Lead Free Solder: Sn-3.0Ag-0.5Cu

4. Optimum Solder Amount for Reflow Soldering

- 4-1. If solder paste is excessive, solder between a chip and a metal terminal melts. This causes the chip to move and come off.
- 4-2. If solder paste is too little, it causes a lack of adhesive strength on the metal terminal and the capacitor comes off.
- 4-3. Please make sure that solder is smoothly applied higher than 0.3mm and lower than the level of the bottom of the chip.

[Standard Conditions for Reflow Soldering] Reflow Temperature (°C Soldering Peak Temperature Gradual 220°C(200°C) Coolina Δ٦ 190°C(170°C) 170°C(150°C) 150°C(130°C) Preheating Time 60 to 120 seconds 30 to 60 seconds Temperature Incase of Lead Free Solder (): In case of Pb-Sn Solder Vapor Reflow Temperature (°C) Solderina Peak Temperature Gradual Cooling 190°C(170°C) 170°C(150°C) 150°C(130°C) Preheating Time 60 to 120 seconds 20 seconds max. [Allowable Reflow Soldering Temperature and Time] 280 Soldering Temperature (°C) 270 7777 260 250 240 230 220 0 30 60 90 120 Soldering Time (sec.)





Inverting the PCB

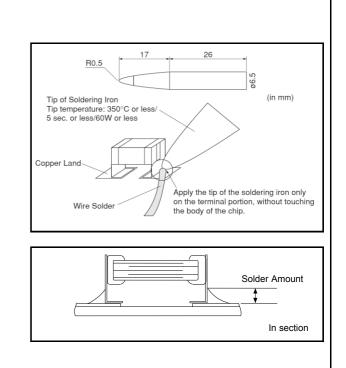
Make sure not to impose any abnormal mechanical shocks to the PCB.

4-2. Flow Soldering

1. Do not apply flow soldering.

4-3. Correction of Soldered Portion

- 1. For the shape of the soldering iron tip, refer to the figure on the right.
- 2. Regarding the type of solder, use a wire diameter of φ 0.5mm or less (rosin core wire solder).
- 3. Apply the tip of the soldering iron against the lower end of the metal terminal.
 - In order to prevent cracking caused by sudden heating of the ceramic device, do not touch the ceramic base directly.
 - (2) In order to prevent deviations and dislocating of the chip, do not touch the junction of the chip and the metal terminal, and the metal portion on the outside directly.
- The amount of solder for corrections by soldering iron, should be lower than the height of the lower side of the chip.

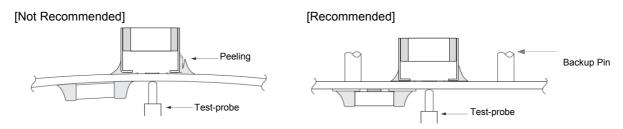


5. Washing

Excessive ultrasonic oscillation during cleaning can cause the PCBs to resonate, resulting in cracked chips or broken solder joints. Take note not to vibrate PCBs.

6. Electrical Test on Printed Circuit Board

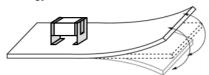
- 1. Confirm position of the backup pin or specific jig, when inspecting the electrical performance of a capacitor after mounting on the printed circuit board.
- 1-1. Avoid bending the printed circuit board by the pressure of a test-probe, etc. The thrusting force of the test probe can flex the PCB, resulting in cracked chips or open solder joints. Provide backup pins on the back side of the PCB to prevent warping or flexing. Install backup pins as close to the capacitor as possible.
- 1-2. Avoid vibration of the board by shock when a test-probe contacts a printed circuit board.



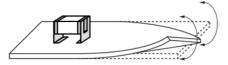
7. Printed Circuit Board Cropping

- 1. After mounting a capacitor on a printed circuit board, do not apply any stress to the capacitor that causes bending or twisting the board.
- 1-1. In cropping the board, the stress as shown at right may cause the capacitor to crack. Cracked capacitors may cause deterioration of the insulation resistance, and result in a short. Avoid this type of stress to a capacitor.

[Bending]



[Twisting]



- 2. Check the cropping method for the printed circuit board in advance.
- 2-1. Printed circuit board cropping shall be carried out by using a jig or an apparatus (Disk separator, router type separator, etc.) to prevent the mechanical stress that can occur to the board.

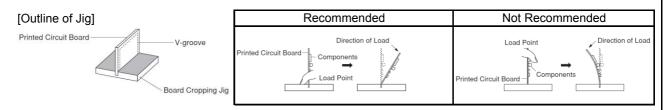
Board Separation Method	Hand Separation	(1) Board Separation Jig	Board Separa	tion Apparatus
Board Separation Method	Nipper Separation	(T) Board Separation Jig	(2) Disk Separator	(3) Router Type Separator
Level of stress on board	High	Medium	Medium	Low
Recommended	×	$ riangle^*$	$ riangle^*$	0
Notes	Hand and nipper separation apply a high level of stress. Use another method.	 Board handling Board bending direction Layout of capacitors 	 Board handling Layout of slits Design of V groove Arrangement of blades Controlling blade life 	Board handling

* When a board separation jig or disk separator is used, if the following precautions are not observed, a large board deflection stress will occur and the capacitors may crack. Use router type separator if at all possible.

(1) Example of a suitable jig

[In the case of Single-side Mounting]

An outline of the board separation jig is shown as follows. Recommended example: Stress on the component mounting position can be minimized by holding the portion close to the jig, and bend in the direction towards the side where the capacitors are mounted. Not recommended example: The risk of cracks occurring in the capacitors increases due to large stress being applied to the component mounting position, if the portion away from the jig is held and bent in the direction opposite the side where the capacitors are mounted.



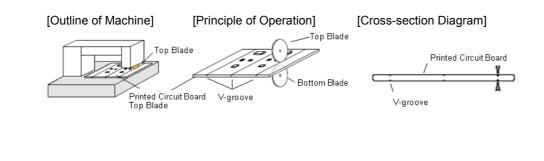
[In the case of Double-sided Mounting]

Since components are mounted on both sides of the board, the risk of cracks occurring can not be avoided with the above method. Therefore, implement the following measures to prevent stress from being applied to the components. (Measures)

- ① Consider introducing a router type separator. If it is difficult to introduce a router type separator, implement the following measures. (Refer to item 1. Mounting Position)
- ② Mount the components at a right angle to the board separation surface.
- ③ When mounting components near the board separation point, add slits in the separation position near the component.
- ④ Keep the mounting position of the components away from the board separation point.
- (2) Example of a Disk Separator

An outline of a disk separator is shown as follows. As shown in the Principle of Operation, the top blade and bottom blade are aligned with the V-grooves on the printed circuit board to separate the board. In the following case, board deflection stress will be applied and cause cracks in the capacitors.

- ① When the adjustment of the top and bottom blades are misaligned, such as deviating in the top-bottom, left-right or front-rear directions
- ② The angle of the V groove is too low, depth of the V groove is too shallow, or the V groove is misaligned top-bottom IF V groove is too deep, it is possible to brake when you handle and carry it. Carefully design depth of the V groove with consideration about strength of material of the printed circuit board.



Reference only

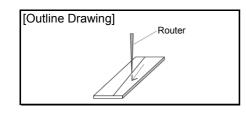
▲ Caution

Decommonded		Not Recomme	ended					
Recommended	Top-bottom Misalignme	ent Left-right Misali	gnment	Front-rear Misalig	Inment			
Top Bla Bottom Bla		o Blade	Top Blade Bottom Blade		Top Blade Bottom Blade			
Example of Recommended Not Recommended								
V-aroove Design	Left-right Misalignment	l ow-Angle	Denth to	o Shallow	Depth too Dee			

V-groove Design	Left-right Misalignment	Low-Angle	Depth too Shallow	Depth too Deep

(3) Example of Router Type Separator

The router type separator performs cutting by a router rotating at a high speed. Since the board does not bend in the cutting process, stress on the board can be suppressed during board separation. When attaching or removing boards to/from the router type separator, carefully handle the boards to prevent bending.



8. Assembly

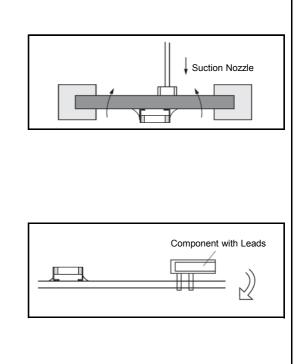
1. Handling

If a board mounted with capacitors is held with one hand, the board may bend. Firmly hold the edges of the board with both hands when handling. If a board mounted with capacitors is dropped, cracks may occur in the capacitors. Do not use dropped boards, as there is a possibility that the quality of the capacitors may be impaired.

- 2. Attachment of Other Components
- 2-1. Mounting of Other Components

Pay attention to the following items, when mounting other components on the back side of the board after capacitors have been mounted on the opposite side. When the bottom dead point of the suction nozzle is set too low, board deflection stress may be applied to the capacitors on the back side (bottom side), and cracks may occur in the capacitors.

- After the board is straightened, set the bottom dead point of the nozzle on the upper surface of the board.
- · Periodically check and adjust the bottom dead point.
- 2-2. Inserting Components with Leads into Boards When inserting components (transformers, IC, etc.) into boards, bending the board may cause cracks in the capacitors or cracks in the solder. Pay attention to the following.
 - Increase the size of the holes to insert the leads, to reduce the stress on the board during insertion.
 - Fix the board with backup pins or a dedicated jig before insertion.
 - Support below the board so that the board does not bend.
 When using multiple backup pins on the board, periodically confirm that there is no difference in the height of each backup pin.



▲ Caution

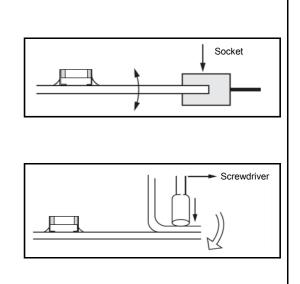
2-3. Attaching/Removing Sockets

When the board itself is a connector, the board may bend when a socket is attached or removed. Plan the work so that the board does not bend when a socket is attached or removed.

2-4. Tightening Screws

The board may be bent, when tightening screws, etc. during the attachment of the board to a shield or chassis.

- Pay attention to the following items before performing the work.
- Plan the work to prevent the board from bending.
- Use a torque screwdriver, to prevent over-tightening of the screws.
- The board may bend after mounting by reflow soldering, etc. Please note, as stress may be applied to the chips by forcibly flattening the board when tightening the screws.



Other

1. Under Operation of Equipment

- 1-1. Do not touch a capacitor directly with bare hands during operation in order to avoid the danger of an electric shock.
- 1-2. Do not allow the terminals of a capacitor to come in contact with any conductive objects (short-circuit). Do not expose a capacitor to a conductive liquid, including any acid or alkali solutions.
- 1-3. Confirm the environment in which the equipment will operate is under the specified conditions. Do not use the equipment under the following environments.
 - (1) Being spattered with water or oil.
 - (2) Being exposed to direct sunlight.
 - (3) Being exposed to ozone, ultraviolet rays, or radiation.
 - (4) Being exposed to toxic gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas, etc.)
 - (5) Any vibrations or mechanical shocks exceeding the specified limits.
 - (6) Moisture condensing environments.
- 1-4. Use damp proof countermeasures if using under any conditions that can cause condensation.

2. Other

- 2-1. In an Emergency
 - (1) If the equipment should generate smoke, fire, or smell, immediately turn off or unplug the equipment. If the equipment is not turned off or unplugged, the hazards may be worsened by supplying continuous power.
 - (2) In this type of situation, do not allow face and hands to come in contact with the capacitor or burns may be caused by the capacitor's high temperature.
- 2-2. Disposal of Waste

When capacitors are disposed of, they must be burned or buried by an industrial waste vendor with the appropriate licenses.

- 2-3. Circuit Design
 - (1) Addition of Fail Safe Function

Capacitors that are cracked by dropping or bending of the board may cause deterioration of the insulation resistance, and result in a short. If the circuit being used may cause an electrical shock, smoke or fire when a capacitor is shorted, be sure to install fail-safe functions, such as a fuse, to prevent secondary accidents.

- (2) Capacitors used to prevent electromagnetic interference in the primary AC side circuit, or as a connection/insulation, must be a safety standard certified product, or satisfy the contents stipulated in the Electrical Appliance and Material Safety Law. Install a fuse for each line in case of a short.
- (3) The KR3, KRM, KC3, KCM series are not safety standard certified products.

2-4. Remarks

Failure to follow the cautions may result, worst case, in a short circuit and smoking when the product is used. The above notices are for standard applications and conditions. Contact us when the products are used in special mounting conditions. Select optimum conditions for operation as they determine the reliability of the product after assembly. The data herein are given in typical values, not guaranteed ratings.

3. Limitation of applications

Please contact us before using our products for the applications listed below which require especially high reliability for the prevention of defects which might directly cause damage to the third party's life, body or property. (1) Aircraft equipment (2) Aerospace equipment (3) Undersea equipment (4) Power plant control equipment

- (5) Medical equipment (6) Transportation equipment (vehicles, trains, ships, etc.) (7) Traffic signal equipment
- (8) Disaster prevention/crime prevention equipment (9) Data-processing equipment exerting influence on public
- (10) Application of similar complexity and/or reliability requirements to the applications listed in the above.

Notice

Rating

1. Operating Temperature

- 1. The operating temperature limit depends on the capacitor.
- 1-1. Do not apply temperatures exceeding the upper operating temperature. It is necessary to select a capacitor with a suitable rated temperature that will cover the operating temperature range. It is also necessary to consider the temperature distribution in equipment and the seasonal temperature variable factor.
- 1-2. Consider the self-heating factor of the capacitor. The surface temperature of the capacitor shall be the upper operating temperature or less when including the self-heating factors.

2. Atmosphere Surroundings (gaseous and liquid)

- 1. Restriction on the operating environment of capacitors.
- 1-1. Capacitors, when used in the above, unsuitable, operating environments may deteriorate due to the corrosion of the terminations and the penetration of moisture into the capacitor.
- 1-2. The same phenomenon as the above may occur when the electrodes or terminals of the capacitor are subject to moisture condensation.
- 1-3. The deterioration of characteristics and insulation resistance due to the oxidization or corrosion of terminal electrodes may result in breakdown when the capacitor is exposed to corrosive or volatile gases or solvents for long periods of time.

3. Piezo-electric Phenomenon

1. When using high dielectric constant type capacitors in AC or pulse circuits, the capacitor itself vibrates at specific frequencies and noise may be generated. Moreover, when the mechanical vibration or shock is added to the capacitor, noise may occur.

Soldering and Mounting

1. PCB Design

- 1. Notice for Pattern Forms
- 1-1. Unlike leaded components, chip components are susceptible to flexing stresses since they are mounted directly on the substrate. They are also more sensitive to mechanical and thermal stresses than leaded components. Excess solder fillet height can multiply these tresses and cause chip cracking. When designing substrates, take land patterns and dimensions into consideration to eliminate the possibility of excess solder fillet height.
- 1-2. There is a possibility of chip cracking caused by PCB expansion/contraction with heat, because stress on a chip is different depending on PCB material and structure. When the thermal expansion coefficient greatly differs between the board used for mounting and the chip, it will cause cracking of the chip due to the thermal expansion and contraction. When small size capacitors of 1005 size or less are mounted on a single-layered glass epoxy board, it will also cause cracking of the chip for the same reason.

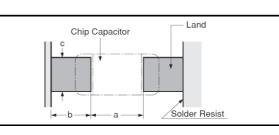
Pattern Forms

	Prohibited	Correct
Placing Close to Chassis	Chassis Solder(ground) Electrode Pattern	Solder Resist
Placing of Chip Components and Leaded Components	Lead Wire	Solder Resist
Placing of Leaded Components after Chip Component	Soldering Iron Lead Wire	Solder Resist
Lateral Mounting		Solder Resist

Notice

2. Land Dimensions

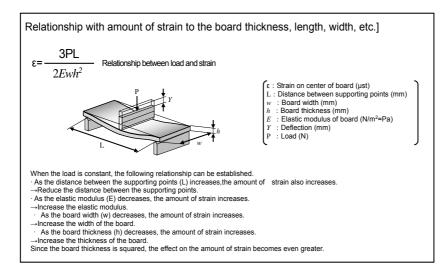
2-1. Chip capacitors can be cracked due to the stress of PCB bending, etc. if the land area is larger than needed and has an excess amount of solder. Please refer to the land dimensions in the following table for reflow soldering. Please confirm the suitable land dimension by evaluating of the actual SET / PCB.



Dimensions Part Number	Chip (L×W)	а	b	с
K□□21	2.0×1.25	1.0 to 1.2	0.6 to 0.7	0.8 to 1.1
K□□31	3.2×1.6	2.2 to 2.4	0.8 to 0.9	1.0 to 1.4
K□□55	5.7×5.0	2.6	2.7	5.6

3. Board Design

When designing the board, keep in mind that the amount of strain which occurs will increase depending on the size and material of the board.



4. Washing

- 1. Please evaluate the capacitor using actual cleaning equipment and conditions to confirm the quality, and select the solvent for cleaning.
- 2. Unsuitable cleaning solvent may leave residual flux or other foreign substances, causing deterioration of electrical characteristics and the reliability of the capacitors.
- 3. Select the proper cleaning conditions.
- 3-1. Improper cleaning conditions (excessive or insufficient) may result in deterioration of the performance of the capacitors.

5. Coating

- 1. A crack may be cause in the capacitor due to the stress of the thermal contraction of the resin during curing process. The stress is affected by the amount of resin and curing contraction. Select a resin with low curing contraction. The difference in the thermal expansion coefficient between a coating resin or a molding resin and the capacitor may cause the destruction and deterioration of the capacitor such as a crack or peeling, and lead to the deterioration of insulation resistance or dielectric breakdown. Select a resin for which the thermal expansion coefficient is as close to that of the capacitor as possible. A silicone resin can be used as an under-coating to buffer against the stress.
- 2. Select a resin that is less hygroscopic. Using hygroscopic resins under high humidity conditions may cause the deterioration of the insulation resistance of a capacitor. An epoxy resin can be used as a less hygroscopic resin.

Notice

Other

1. Transportation

- 1. The performance of a capacitor may be affected by the conditions during transportation.
- 1-1. The capacitors shall be protected against excessive temperature, humidity, and mechanical force during transportation.
 - (1) Climatic condition
 - low air temperature : -40°C
 - change of temperature air/air : -25°C/+25°C
 - low air pressure : 30kPa
 - change of air pressure : 6kPa/min.
 - (2) Mechanical condition

Transportation shall be done in such a way that the boxes are not deformed and forced are not directly passed on to the inner packaging.

- 1-2. Do not apply excessive vibration, shock, or pressure to the capacitor.
 - (1) When excessive mechanical shock or pressure is applied to a capacitor, chipping or cracking may occur in the ceramic body of the capacitor.
 - (2) When the sharp edge of an air driver, a soldering iron, tweezers, a chassis, etc. impacts strongly on the surface of the capacitor, the capacitor may crack and short-circuit.
- 1-3. Do not use a capacitor to which excessive shock was applied by dropping, etc. A capacitor dropped accidentally during processing may be damaged.

2. Characteristics Evaluation in the Actual System

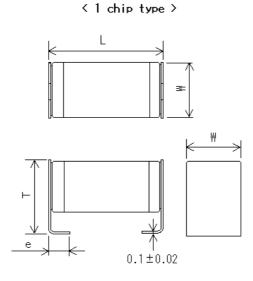
- 1. Evaluate the capacitor in the actual system, to confirm that there is no problem with the performance and specification values in a finished product before using.
- 2. Since a voltage dependency and temperature dependency exists in the capacitance of high dielectric type ceramic capacitors, the capacitance may change depending on the operating conditions in the actual system. Therefore, be sure to evaluate the various characteristics, such as the leakage current and noise absorptivity, which will affect the capacitance value of the capacitor.
- 3. In addition, voltages exceeding the predetermined surge may be applied to the capacitor by the inductance in the actual system. Evaluate the surge resistance in the actual system as required.

A Note

- 1. Please make sure that your product has been evaluated in view of your specifications with our product being mounted to your product.
- 2. You are requested not to use our product deviating from this specification.

1. Application This specification is	applied to I	Metal Terminal Tvn	e Multilaver	Ceramic	Capacitors K	RM series	
used for General El Do not use these pro	ectronics e oducts in ar	quipment. ny automotive pow	-				
chargers for electric	vehicles ar	nd plug-in hybrids.					
2. Rating 2-1. Operating tempera	ature range	-55 to +8	5°C				
2-2. Part name config ex.) <u>KRM 21</u>	uration F	R6	1E	226	М	HA1	К
Series Chip	Height n dimensio			bacitance		Individual specificatio	
•Chip dimens	sion(L×W)						
	Code	Nominal Chip di L	imension (m W	nm)			
Ľ	21	2.0	1.25				
 Height dimer 	sion						
	Code	Dimensio					
-	E F	<u> </u>					
L							
Please re	efer to [Part	number list] on th	e dimensior	ns of meta	al terminal pro	oduct.	
 Temperature 	-						
-	Code R6	Temperature o X5		ic			
P	-	rm detailed specifi		pecificati	on and test m	ethods].	
 Rated voltage 	0						
•Naleu voltagi	Code	Rated v	voltage				
_	1C	DC1					
L	1E	DC2	25V				
•Capacitance The first tw Ex.) In cas	e 226.	note significant figu		st digit de	enotes the mul	Itiplier of 10	in pF.
	22x10° =	= 22000000pF(=22	2μF)				
•Capacitance Please refe		umber list].					
 Individual spe Murata's co 							
Please refe	er to [Part i	number list].					
 Packing style)						
	Code	Sty					
L	K	φ330mm reel	Plastic tapi	ng			

3. Part number list



Unit : mm

	DC	0	Cap.			C	Dimensio	on(mm	ı)		Pack
T.C.	Rated Volt. (V)	Cap. (μF)	tol. (%)	Customer Part Number	Murata Part Number	L	w	т	е	Chip type	atv.
X5R	16	10	±10		KRM21ER61C106KHA1K	2.2 ±0.2	1.25 ±0.2	1.8 ±0.1	0.7 ±0.2	1	8000
X5R	25	10	±10		KRM21ER61E106KHA1K	2.2 ±0.2	1.25 ±0.2	1.8 ±0.1	0.7 ±0.2	1	8000
X5R	25	22	±20		KRM21FR61E226MHA1K	2.2 ±0.3	1.25 ±0.3	1.9 ±0.1	0.7 ±0.2	1	8000

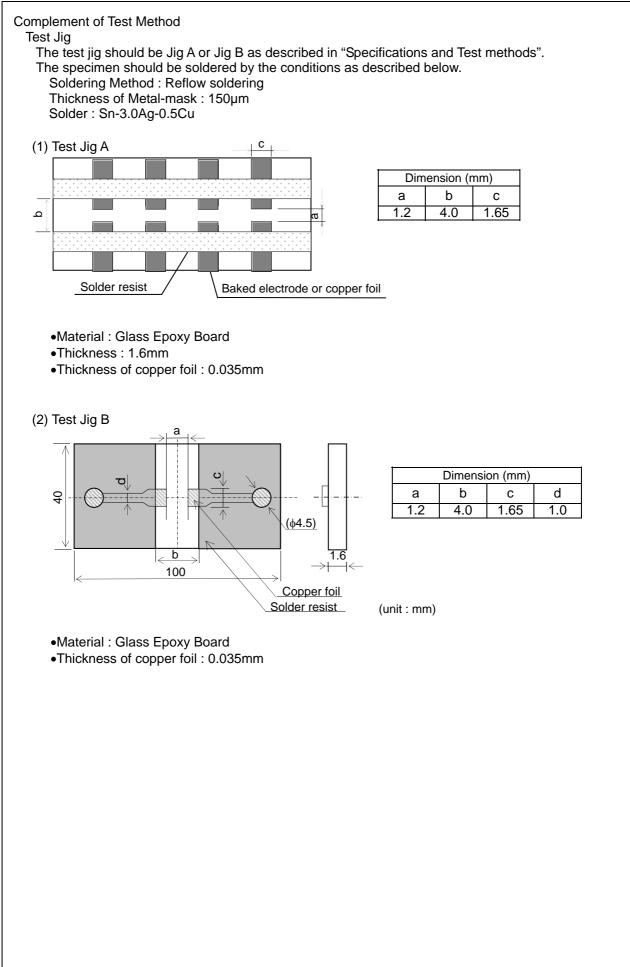
ETKRM2103A

4. Si	pecifications and t	est methods									
No.	Item		S	pecificat	tions				Test metho	d	
1	Operating temperat	ure range	-55 to +85°C								
2	Appearance		No defects o	r abnor	malities	١	Visual i	nspectio	on.		
	Dimensions		Within the sp	pecified	dimension.				and microme	ters.	
	Dielectric strength		No defects c			l i f	No failu in the ta for 1 to current Rate	ire shou ble is a 5 s, pro	Ild be observe pplied betwee ovided the cha than 50mA. e Te	ed when v en the trm	inations large
5	Insulation resistanc	e(I.R.)	50MΩ·μF or	more		r	The ins measur	ulation ed with	resistance sh rated voltage	ould be	0
6	Capacitance		Within the sp	becified	tolerance.	r	The cap referen	ce temp	ging. ce/D.F.should perature at the voltage show	e meaning	1
7	Dissipation Factor (D.F.)	0.15 max.				Noi	minal	Measuring	Measu	ring
								citance 10 μ F	frequency 120±24Hz	volga AC0.5±0 (r.m.s	0.1V
							C≦	10 μ F	1±0.2kHz	AC1.0±0 (r.m.s	0.2V
8	Capacitance Temperature Characteristics		within ±15% (Temp.Ra	nge:-55	to +85°C)	r • I f	made a Pretrea Perform for 60±	t each s atment i the he	ce measurem step specifiec eat treatment nd then let sit *.	l in the tat at 150+0/·	ole. -10°C
			Step	1		2		3	4		5
			Temp.(°C)	25±2	Min. Opera		Temp. ±3	3 25±2	4 Max. Operati	ing Temp. ±2	5 25±2
9	Vibration resistance	Appearance Capacitance D.F.	No defects o Within the sp Pass the iter	pecified n No.7.	tolerance.		epoxy b method The cap simple l amplitur varied u imits of The free return to approxi This mo 2 h in e directio	poard) s pacitor s harmon de of 1. uniforml 10 and quency o 10Hz, mately otion sh ach of 3 ns (tota	ould be appli 3 mutually pe l of 6 h).	nplement ojected to ving a tota quency be ne approxi 10 to 55H; aversed ir ed for a pe rpendicula	of test a l ing mate z and i eriod of
10	Solderability of termination		The metal su	irtace is	soldered w	- r f f 3	The are Let sit for measur Pretrea Perform for 60±	ea of so or 24±2 e. atment n the he	20 to 40	2 min., 20 ondition*, t at 150+0/- for 24±2 260	hen -10°C
* "	room condition" Te	mperature:15	to 35°C, Rela	ative hu	midity:45 to		100°C	150°C	60 to 1		\

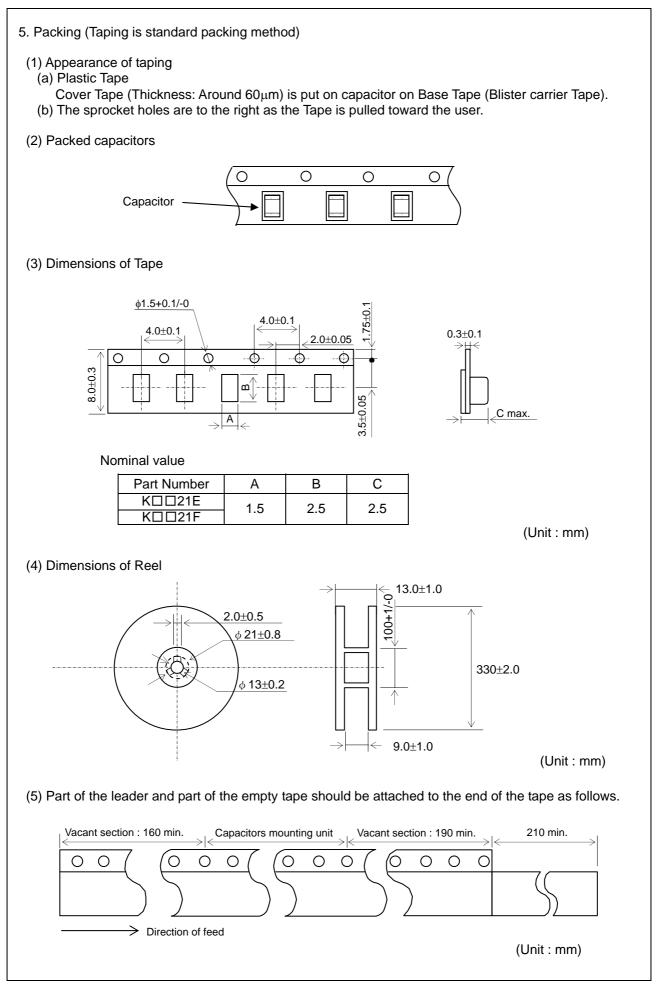
soldering heat Capacitance D.F. Pass the item No.7. In a soldering iron case Temp. of solder: 35010°C Solder the iron No.5. Them of solder: 35010°C Solder the 4+1/-0 s Let sit for 24±2 h at room condition*, then measure. Please refer to f ▲Caution 4-3. Correctio of Soldered Portion. 12 Adhesive strength of termination No removal of the terminations or other defects should occur. Solder the capacitor to the Test Jig A (glass epoxy board) shown in *Complement of terminations or other defects. 13 Deflection No marking defects. Solder the capacitor to the Test Jig B (glass epoxy board) shown in *Complement of termination of termination 14 Strength of metal terminal Termination not to be broken or loosened. Solder the capacitor to the set Jig B (glass epoxy board) shown in *Complement of termination of 10N using a pressure ging should be applied to the center in the direction of the supporting Test Jig (glass epoxy board) shown in *Complement of test method ⁷ . •Flexure : Srm 14 Strength of metal terminal Termination not to be broken or loosened. A static load of 10N using a pressure ging should be applied to the center in the direction of the sarrow and held for 10 s. Pressure (glass epoxy board) shown in *Complement of test method ⁷ . •Flexure : Srm 15 Temperature cycle Appearance Appearance change No marking defects. Capacitance change Fix the capacitor to the supporting Test Jig (glass epoxy board) shown in *Complement of test method ⁷ . •Flexure : Sind diffection 16 Temperature cycle A	No.	Item		Specifications	Test method
Defining Pass the item No.7. IR. Pass the item No.5. Dielectric Strength IR. Pass the item No.5. Dielectric Strength IR. Pass the item No.5. Dielectric Strength IR. Pass the item No.4. IR. Pass the item No.4. IR. State Strength IR. No removal of the terminations IR. The apply 10k force in the Test Jig Eglass the item No.4. IR. The apply 10k force in the direction of the arrow. IR. The apply 10k force in the direction show The state of the arrow and bid of the arrow in "Complement of the method". IR. The apply 10k force in the direction show The state of the arrow and held of the arrow and held of the arrow in the direction of the arrow and held of the arrow and	11		Appearance	No marking defects.	Reflow Soldering
D.F. Pass the item No.7. In a soldering item case IR. Pass the item No.4. Top of solder: 350 if 0°C Solder ime: 4+1/-0.5 Solder ime: 4+1/-0.5 Let sit for 24.2.2 hat soom condition*, then measure. IP. Pass the item No.4. Figs of the capacitor to the Test Jig A (gas some refer to 1 @Caution 4-3. Correction of Solder: Boacacitor to the Test Jig A (gas some refer to 1 @Caution 4-3. Correction of the terminations of other defects should occur. IP. Solder the capacitor to the Test Jig A (gas some refer to 1 @Caution 4-3. Correction of the termination of the measure. IP. Solder the capacitor to the Test Jig A (gas some refer to 1 @Caution 4-3. Correction of the termination of the measure. IP. Solder the capacitor to the Test Jig B (gas some refer to 1 @N force in the direction show of the termination on to be broken or test the termination on to be broken or loosened. Solder the capacitor to the Test Jig B (gas some refer to 1 @N using apply the force in the direction show of test method? IP. Strength of metal terminal Tormination not to be broken or loosened. Fix the capacitor to the supporting Test Jig Concerning test Jig Concerning the test mode of test transmitiant test in the apply the force some and held for 10 s. IP. Pass the item No.5. Fix the capacitor to the supporting Test Jig Concerning Test Jig Concerning Test Jig Concerning Test Jig Concerning Test Jig Concernig Test Jig Concerning Test Jig Concerning Test Jig Conce		soldering heat		Within ±10%	 See Item 10 Solderability of termination
LR. Pass the item No.5. Difference Pass the item No.4. The solid if .300.10°C Bill of the solid if .300.10°C Strength The solid if .300.10°C Idease refer to factor if .300.10°C Strength The solid if .300.10°C Idease refer to factor if .300.10°C The solid if .300.10°C The solid if .300.10°C Idease refer to factor if .300.10°C The solid if .300.10°C The solid if .300.10°C Idease refer to factor if .300.10°C The solid if .300.10°C The solid if .300.10°C Idease refer to factor if .300.10°C The solid if .300.10°C The solid if .300.10°C Idease refer to factor if .300.10°C The solid if .300.10°C The solid if .300.10°C Idease refer to factor if .300.10°C The solid if .300.10°C The solid if .300.10°C Idease refer to factor if .300.10°C The solid if .300.10°C The solid if .300.10°C Idease refer to factor if .300.10°C The solid if .300.10°C The solid if .300.10°C Idease refer to factor if .300.10°C The solid if .300.10°C The solid if .300.10°C Idease refer to factor if .300.10°C The solid if .300.10°C The solid if .300.10°C Idease refer to factor if .300.			change		
Lite Pass the term No.5. Diffective Pass the term No.4. Solder 1: 50:410°C Solder time: 44.1/0.5 Let si for 24.2 h at room condition*, then measure. Please refer to Image term in the direction of the terminations Solder the capacitor to the Test Jig A (glass or other defects should occur. 12 Adhesive strength No removal of the terminations Solder the capacitor to the Test Jig A (glass or other defects should occur. 13 Deflection No marking defects. Solder the capacitor to the Test Jig A (glass epoxy badd) shown in "Complement of termination" 14 Strength of metal terminal Termination not to be broken or loosened. Solder the capacitor to the Test Jig A (glass epoxy badd) shown in "Complement of the method". 15 Temperature Appearance No marking defects. Pressure for the direction of "Complement of termination on to be broken or loosened. 16 Temperature Appearance No marking defects. Pressure for the following the force in the direction of the capacitor to the supporting Test Jig A (glass epoxy board) shown in "Complement of termination". 16 Temperature Appearance No marking defects. Pressure for to the supporting Test Jig A (glass epoxy board) shown in "Complement of terminatin termintent ing to the capacitor to the supporting Test Jig A (g					In a soldering iron case
Solder time: 44 1/0 s Solder time: 44 1/0 s Let sit for 24.2 h at coom condition*, then measure. Please refer to 'Accaution 4-3. Correctio of Soldered Portion] Solder the capacitor to the Test Jig A (glass provided) shown in "Complement of the measure. Them apply 10N force in the direction of the terminations or other defects should occur. Solder the capacitor to the Test Jig A (glass provided) shown in "Complement of the measure. Them apply 10N force in the direction of the terminations or other defects. Solder the capacitor to the Test Jig B (glass epoxy board) shown in "Complement of the method". Them apply 10N force in the direction shown "Test Method". The apply the force in the direction shown "Test Method". If Strength of metal terminal Termination not to be broken or lossened. Iossened. A static load Iossened. A static load or the supporting Test Jig (glass epoxy board) shown in "Complement of the measure. If Temperature Appearance Opticities according to the test intern No.4. Test test intern No.4. If Manual Accord action of the test intern No.4. Test action of the supporting Test Jig Action of the measure. If Temperature Appearance No marking defects. Optic Pass the tem No.7. If Manual Accord actes at tho				Pass the item No.5.	
Identifyin Let is for 24.24 hat room condition*, then measure. Please refer to 1 Cocution 4-3. Correction of Solder the capacitor to the Test Jig A (glass of terminations or other defects should occur. Solder the capacitor to the Test Jig A (glass Epony Board 13 Deflection No marking defects. Solder the capacitor to the Test Jig A (glass Epony Board 13 Deflection No marking defects. Solder the capacitor to the Test Jig B (glass Epony Board 14 Strength of metal terminal Termination not to be broken or loosened. Solder the capacitor to the Test Jig B (glass Epony Board 15 Temperature Appearance No marking defects. Pressure Srm 16 Temperature Appearance No marking defects. Pressure I the direction of the capacitor to the supporting Test Jig C (glass epony board) shown in "Complement of test method". 15 Temperature Appearance No marking defects. Pressure I the capacitor to the supporting Test Jig C (glass epony board) shown in "Complement of test method". 16 Temperature Appearance No marking defects. Pressure I the Capacitor to the supporting Test Jig C (glass epony board) shown in "Complement of test method". 16 Temperature Appearance No marking defects. Pressure I the Capacitor to the supporting Test Jig C (glass accore the ca				Pass the item No.4.	
Image: Plass refer to Cacution 4-3. Correction of Soldered Portion. I2 Adhesive strength of terminations or other delects should occur. I2 Adhesive strength of terminations or other delects should occur. I3 Deflection I3 Deflection I4 Strength of metal terminal I5 Term apply 10N force in the direction of the apply to the Test Jig A (Jass Epoxy Board) shown in "Complement of the method". I4 Strength of metal terminal Termination not to be broken or incoment. I6 Appearance No marking defects. I7 Temperature Appearance I8 Strength Pass the item No 7. I8 Termination at to be broken or in Cost and any thin a 7.5% I8 Temperature Appearance I9 Estime Mo 7. Fix the capacitor to the supporting Test Jig (Jass epoxy board) shown in "Complement of th			strength		
12 Adhesive strength of termination No removal of the terminations or other delects should occur. Please refer to [Acaution 4-3. Correction of Soldered Portion]. 13 Deflection No marking defects. Figure 10N, 10a1 s Glass Epoxy Board 13 Deflection No marking defects. Solder the capacitor to the Test Jig A glass Glass Epoxy Board 14 Strength of metal terminal Termination not to be broken or locoened. Solder the capacitor to the Test Jig A glass Glass Epoxy Board 15 Temperature Appearance No marking defects. Pressure for the direction shown in "Complement of test method". 16 Temperature Appearance No marking defects. Pressure for the Test Jig A glass provide to the capacitor of the Test Jig A glass provide to the capacitor of the Test Jig A glass provide to the capacitor of the direction of the arrow and help of test method". 16 Temperature Appearance No marking defects. Pressure for the 100 mm (ming test Jig A form the 100 cycles according to the direct method". 16 Like Pass the item No.5. Perform the 100 cycles according to the direct method". Heat treatments listed in the following tat a Room Tempe. 2 to 3. 3 Max Operating Temp. 2 to 3. 3 Max O					
i desive strength of termination No removal of the terminations or other defects should occur. of Solder the capacitor to the Test. Lig A (gias goay board) shown in "Complement of Te method". Then apply 10N force in the direction of th arrow. 13 Deflection No marking defects. Solder the capacitor to the Test. Lig B (giass epoxy board) shown in "Complement of te method". Then apply the force in the direction shown Test Method of the capacitor to the Test. Lig B (giass epoxy board) shown in "Complement of te method". 14 Strength of metal terminal Termination not to be broken or loosened. Fix the capacitor to the Test. Lig B (giass epoxy board) shown in "Complement of te method". 15 Temperature cycle Appearance Defection No marking defects. 16 Temperature cycle Appearance D (Fe, D Fe, D Fe,					•
12 Adhesive strength or dier defects should occur. File apply 10N force in the direction of the method". Then apply 10N force in the direction of th arrow. Solder the capacitor to the Test Lija K[diss Giass Epoxy Board] 13 Deflection No marking defects. Solder the capacitor to the Test Lija K[diss Giass Epoxy Board] 14 Strength of metal terminal Termination not to be broken or loosened. Solder the capacitor to the Test Lija K[diss epoxy board] shown in "Complement of te method". Then apply the force in the direction shown "Test method". 14 Strength of metal terminal Termination not to be broken or loosened. Fix the capacitor to the supporting Test Lija (diass epoxy board] shown in "Complement of test method". 15 Temperature cycle Appearance D.F. No marking defects. Fix the capacitor to the supporting Test Lija (diass epoxy board] shown in "Complement of test method". 15 Temperature cycle Appearance D.F. No marking defects. Fix the capacitor to the supporting Test Lija (diass epoxy board] shown in "Complement of test method". 16 Humidity (Steady state) Appearance D.F. No marking defects. Fix the capacitor to the supporting Test Lija (diass epoxy board] shown in "Complement of test method". State 2 moon method 2 moon sold to the capacitor to the supporting Test Lija (diass epoxy board] shown in "Complement of test method". 16 Humidity (D.F. Pass the item No.4.					Please refer to Caution 4-3. Correction
of termination or other defects should occur. epoxy board) shown in "Complement of Temethod". Then apply 10N force in the direction of th arrow. 13 Deflection No marking defects. Solder the capacitor to the Test Jig Rights: epoxy board is the direction shown in "Complement of the method". 14 Strength of metal terminal Termination not to be broken or loosened. Solder the capacitor to the Test Jig Rights: epoxy board is the direction shown in "Complement of "Complement of "Complement of "Complement of "Complement of "Complement of the method". 15 Termination not to be broken or cycle A static load of 10N using a pressure of the applied to the supporting Test Jig Rights and the direction of the arrow and held for 10 s. Pressure of the applied to the supporting Test Jig Rights and the direction of the arrow and held for 10 s. 15 Temperature Appearance No marking defects. Pressure of the applied to the supporting Test Jig Rights and the direction of the arrow and held for 10 s. 16 Temperature Appearance No marking defects. Perform the 100 cycles according to the active method and the rest in the following lat the following lat the following lat the following lat the active the applied to the local to the supporting Test Jig Rights and the lat the attreatment at 150-0/10°C for 605 min and then let sit for 24±2 h at room condition", then measure. 16 Humidity Appearance No marking defects. The capacitor at 40±2°C and relative nor condition", the measure. <					of Soldered Portion
of termination or other defects should occur. epoxy board) shown in "Complement of Temethod". Then apply 10N force in the direction of th arrow. 13 Deflection No marking defects. Solder the capacitor to the Test Jig Rights: epoxy board is the direction shown in "Complement of the method". 14 Strength of metal terminal Termination not to be broken or loosened. Solder the capacitor to the Test Jig Rights: epoxy board is the direction shown in "Complement of "Complement of "Complement of "Complement of "Complement of "Complement of the method". 15 Termination not to be broken or cycle A static load of 10N using a pressure of the applied to the supporting Test Jig Rights and the direction of the arrow and held for 10 s. Pressure of the applied to the supporting Test Jig Rights and the direction of the arrow and held for 10 s. 15 Temperature Appearance No marking defects. Pressure of the applied to the supporting Test Jig Rights and the direction of the arrow and held for 10 s. 16 Temperature Appearance No marking defects. Perform the 100 cycles according to the active method and the rest in the following lat the following lat the following lat the following lat the active the applied to the local to the supporting Test Jig Rights and the lat the attreatment at 150-0/10°C for 605 min and then let sit for 24±2 h at room condition", then measure. 16 Humidity Appearance No marking defects. The capacitor at 40±2°C and relative nor condition", the measure. <	12	Adhesive strength		No removal of the terminations	Solder the capacitor to the Test Jig A (glass
Image: start of the start		of termination		or other defects should occur.	epoxy board) shown in "Complement of Test
arrow. arrow. 13 Deflection No marking defects. 13 Deflection No marking defects. 14 Strength of metal terminal Termination not to be broken or locsened. 14 Strength of metal terminal Termination not to be broken or locsened. 15 Temperature Capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". 15 Temperature Capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". 15 Temperature Capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". 15 Temperature Capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". 16 Mithin ±7.5% 17 Pass the item No.5. 18 Termination defects. 19 Term the 100 cycles according to the 4 heat treatments listed in the following tat test method". 19 Termination defects. 19 Termination defects. 10.F. Pass the item No.5. 11 Pass the item No.4. 12 Moc Capacitor on condition", then measure. 13 Max Caperating Temp.2 2 30:43 16 H					method".
13 Deflection No marking defects. Solder the capacitor to the Test Jig B(glass pory board) shown in "Complement of test method". 14 Strength of metal terminal Termination not to be broken or lossened. A static load of Deflection of "Compleme of test method". 15 temperature A paperance No marking defects. Fix the capacitor to the supporting Test Jig B(glass caps) board) shown in "Compleme of test method". 16 temperature Appearance No marking defects. Fix the capacitor to the supporting Test Jig B(glass caps) board) shown in "Compleme of test method". 15 temperature Appearance No marking defects. Fix the capacitor to the supporting Test Jig B(glass caps) board) shown in "Compleme of test method". 16 temperature Appearance No marking defects. Fix the capacitor to the supporting Test Jig B(glass caps) board) shown in "Compleme of test method". 16 temperature Appearance No marking defects. Fix the capacitor to the supporting Test Jig B(glass caps) board) shown in "Compleme of test method". 16 test method". Test bettod to b cycles according to the test method. Heat treatments listed in the following at the supporting Test Jig B(glass caps) board) shown in "Compleme of test method". 16 the capacitor of Apperature. No marking defects. Test test method					
3 Deflection No marking defects. Solder the capacitor to the Test Jig Eglass epoxy board) shown in "Complement of temethod". 13 Deflection No marking defects. Solder the capacitor to the Test Jig Eglass epoxy board) shown in "Complement of temethod". 14 Strength of metal terminal Termination not to be broken or lossened. A static load of Deflection" of "Complement of temethod". 15 Temperature (Appearance) No marking defects. Fix the capacitor to the supporting Test Jig for the direction of the arrow and head the direction of the arrow and head the direction of the direction of the arrow and head the direction of the dire					arrow.
3 Deflection No marking defects. Solder the capacitor to the Test Jig Eglass epoxy board) shown in "Complement of temethod". 13 Deflection No marking defects. Solder the capacitor to the Test Jig Eglass epoxy board) shown in "Complement of temethod". 14 Strength of metal terminal Termination not to be broken or lossened. A static load of Deflection" of "Complement of temethod". 15 Temperature (Appearance) No marking defects. Fix the capacitor to the supporting Test Jig for the direction of the arrow and head the direction of the arrow and head the direction of the direction of the arrow and head the direction of the dire					
3 Deflection No marking defects. Solder the capacitor to the Test Jig Eglass epoxy board) shown in "Complement of temethod". 13 Deflection No marking defects. Solder the capacitor to the Test Jig Eglass epoxy board) shown in "Complement of temethod". 14 Strength of metal terminal Termination not to be broken or lossened. A static load of Deflection" of "Complement of temethod". 15 Temperature (Appearance) No marking defects. Fix the capacitor to the supporting Test Jig for the direction of the arrow and head the direction of the arrow and head the direction of the direction of the arrow and head the direction of the dire					10N 10+1 s
13 Deflection No marking defects. Solder the capacitor to the Test Jig B(glass epoxy board) shown in "Complement of termethod". Then apply the force in the direction show in "Complement of termethod". These applied to a Complement of termethod in Complement of termethod. 14 Strength of metal terminal Termination not to be broken or loosened. A static load of Complement of termethod. 15 Temperature Capacitor with the former of test method. Appearance No marking defects. 15 Temperature Capacitor with the former of test method. Pressure with the former of the supporting Test Jig (glass epoxy board) shown in "Complement of test method." 16 Temperature Capacitor with the following tat. Pass the item No.5. 17. Pass the item No.5. Dielectric 18. Dielectric Pass the item No.4. 16 Humidity Appearance Within ±15% Site the capacitor to the component of the measure. 16 Humidity Appearance No marking defects. Site the capacitor at 40±2*C and relative humidity.45 to 75%, Atmosphere pressure.86 to 106kPa 16 Humidity Appearance No marking defects. Site the capacitor at 40±2*C and relative humidity.45 to 75%, Atmosphere pressure.86 to 106kPa 17 Pass the item No.4. Site the capacitor at 40±2*C and relative humidity.45 to 75%, Atmosphere pressure.86 to					
13 Deflection No marking defects. Solder the capacitor to the Test Jig B(glass epoxy board) shown in "Complement of termethod". Then apply the force in the direction show in "Complement of termethod". These applied to a Complement of termethod in Complement of termethod. 14 Strength of metal terminal Termination not to be broken or loosened. A static load of Complement of termethod. 15 Temperature Capacitor with the former of test method. Appearance No marking defects. 15 Temperature Capacitor with the former of test method. Pressure with the former of the supporting Test Jig (glass epoxy board) shown in "Complement of test method." 16 Temperature Capacitor with the following tat. Pass the item No.5. 17. Pass the item No.5. Dielectric 18. Dielectric Pass the item No.4. 16 Humidity Appearance Within ±15% Site the capacitor to the component of the measure. 16 Humidity Appearance No marking defects. Site the capacitor at 40±2*C and relative humidity.45 to 75%, Atmosphere pressure.86 to 106kPa 16 Humidity Appearance No marking defects. Site the capacitor at 40±2*C and relative humidity.45 to 75%, Atmosphere pressure.86 to 106kPa 17 Pass the item No.4. Site the capacitor at 40±2*C and relative humidity.45 to 75%, Atmosphere pressure.86 to					
Id Strength of metal terminal Termination not to be broken or loosened. Then apply the force in the direction show "Test Method of Deflection" of "Complement of termethod". Id Strength of metal terminal Termination not to be broken or loosened. A static load of 10N using a pressure jig should be applied to the center in the direction of the arrow and held for 10 s. Pressure y 0.5L, ↓ I5 Temperature cycle Appearance diarge No marking defects. Fix the capacitor to the supporting Test Jig (glass epoxy beard) shown in "Complement of test method". I5 Temperature cycle No marking defects. Fix the capacitor to the supporting Test Jig (glass epoxy beard) shown in "Complement of test method". I5 Temperature cycle No marking defects. Fix the capacitor to the supporting test Jig (glass epoxy beard) shown in "Complement of test method". I5 Temperature cycle No marking defects. Fix the capacitor to the supporting test Jig (glass epoxy beard) shown in "Complement of test method". I6 Humidity Appearance Dielectric No marking defects. I7. Pass the item No.4. Site for 24±2 h at room condition", then measure. I6 Humidity Appearance Capacitor at 40±2"C and relative Dielectric Dielectric No marking defects. I7. D.2 max. Dielectric Capacitor at 15040'.10°C for 6025 min and then let sit for 24±2 h at room condition", then measure. I7. D.2 max.<					∑ Glass Epoxy Board
Id Strength of metal terminal Termination not to be broken or loosened. Then apply the force in the direction show "Test Method of Deflection" of "Complement of termethod". Id Strength of metal terminal Termination not to be broken or loosened. A static load of 10N using a pressure jig should be applied to the center in the direction of the arrow and held for 10 s. Pressure y 0.5L, ↓ I5 Temperature cycle Appearance diarge No marking defects. Fix the capacitor to the supporting Test Jig (glass epoxy beard) shown in "Complement of test method". I5 Temperature cycle No marking defects. Fix the capacitor to the supporting Test Jig (glass epoxy beard) shown in "Complement of test method". I5 Temperature cycle No marking defects. Fix the capacitor to the supporting test Jig (glass epoxy beard) shown in "Complement of test method". I5 Temperature cycle No marking defects. Fix the capacitor to the supporting test Jig (glass epoxy beard) shown in "Complement of test method". I6 Humidity Appearance Dielectric No marking defects. I7. Pass the item No.4. Site for 24±2 h at room condition", then measure. I6 Humidity Appearance Capacitor at 40±2"C and relative Dielectric Dielectric No marking defects. I7. D.2 max. Dielectric Capacitor at 15040'.10°C for 6025 min and then let sit for 24±2 h at room condition", then measure. I7. D.2 max.<	13	Deflection		No marking defects.	Solder the capacitor to the Test Jig B(glass
14 Strength of metal terminal Termination not to be broken or loosened. A static load of 100 using a pressure ig should be applied to the center in the direction of test method?. 15 Temperature cycle Appearance No marking defects. Cycle Fix the capacitor to the supporting Test Jig (class epoxy board) showing taken of the test method?. 15 Temperature cycle Appearance No marking defects. Cycle Fix the capacitor to the supporting Test Jig (class epoxy board) showing taken of the test method?. 16 Temperature cycle Appearance No.7. Perform the 100 cycles according to the following taken of the test method?. 17 Temperature cycle Appearance No.7. Perform the 100 cycles according to the following taken of the test method?. 16 I.R. Pass the item No.5. Perform the 100 cycles according to the following taken of the test method?. 16 Humidity Appearance No marking defects. Tem Temp. 22 30a3 3 4 4 500/10°C for 60.54 to 1500/24.24 b 1 to com condition?, then measure. 16 Humidity Appearance No marking defects. Sit the capacitor at 40±2°C and relative humidity.45 to 75%, Atmosphere pressure 36 to 106kPa 17 Temperature:15 to 35°C, Relative humidity.45 to 75%, Atmosphere pressure:86 to 106kPa **room condition*.	-				epoxy board) shown in "Complement of test
14 Strength of metal terminal Termination not to be broken or loosened. A static load of 10N using a pressure in should be applied to the conter in the direction of the arrow and held for 10 s. Pressure (i) pressure is should be applied to the conter in the direction of the arrow and held for 10 s. 15 Temperature Capacitance in the direction of the arrow and held for 10 s. Appearance is should be applied to the arrow and held for 10 s. Fix the capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". 15 Temperature Capacitance is the item No.7. Perform the 100 cycles according to the D.F. Pass the item No.7. 16 I.R. Pass the item No.5. Perform the 100 cycles according to the for 0.2 as the item No.4. 17 Perform the 100 cycles according to the for 60.5 min and then let sit for 24.4 b at room condition". Terms (min measure. 16 Humidity Appearance D.F. 0.2 max. Stit the capacitor at 042°C and relative change 0.F. 0.2 max. - 0.2 max. - 17. Pass the item No.4. Stit the capacitor at 042°C and relative for 60.45 min and then let sit for 24.42 h at room condition". 16 Humidity Appearance D.F. 0.2 max. - 17. 0.2 max. - - 18. 0.2 max.					method".
14 Strength of metal terminal Termination not to be broken or loosened. A static load of 10N using a pressure in should be applied to the conter in the direction of the arrow and held for 10 s. Pressure (i) pressure is should be applied to the conter in the direction of the arrow and held for 10 s. 15 Temperature Capacitance in the direction of the arrow and held for 10 s. Appearance is should be applied to the arrow and held for 10 s. Fix the capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". 15 Temperature Capacitance is the item No.7. Perform the 100 cycles according to the D.F. Pass the item No.7. 16 I.R. Pass the item No.5. Perform the 100 cycles according to the for 0.2 as the item No.4. 17 Perform the 100 cycles according to the for 60.5 min and then let sit for 24.4 b at room condition". Terms (min measure. 16 Humidity Appearance D.F. 0.2 max. Stit the capacitor at 042°C and relative change 0.F. 0.2 max. - 0.2 max. - 17. Pass the item No.4. Stit the capacitor at 042°C and relative for 60.45 min and then let sit for 24.42 h at room condition". 16 Humidity Appearance D.F. 0.2 max. - 17. 0.2 max. - - 18. 0.2 max.					Then apply the force in the direction shown in
If Strength of metal terminal Termination not to be broken or loosened. A static load of 10N using a pressure iig should be explied to the center in the direction of the supporting Test Jig (glass epoxy board) shown in "Complement of tast method". I5 Temperature cycle Appearance D.F. No marking defects. Capacitance d'ange Fix the capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". I5 Temperature cycle Appearance D.F. No marking defects. Capacitance d'ange Fix the capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". I6 Humidity Pass the item No.7. Heat treatments listed in the following tat the treatments listed in the following tat the following tat strength I6 Humidity Appearance No marking defects. Sit the capacitor at 40±2°C and relative humidity 90 to 95% for 500±24±2 h at room condition". I6 Humidity Appearance No marking defects. Sit the capacitor at 40±2°C and relative humidity 90 to 95% for 500±24±2 h at room condition". I7 Les Mouger D.F. 0.2 max. Capacitance within ±15% Sit the capacitor at 40±2°C and relative humidity 90 to 95% for 500±24±2 h at room condition". I7 I7.5. 0.2 max. Capacitance Sit the capacitor at 40±2°C and relative humidity 90 to 95% for 500±24±2 h at room condition". I7 I7.5. 0.2 max. Sit					"Test Method of Deflection" of "Complement
14 Strength of metal terminal Termination not to be broken or loosened. -Hold time: 5 s 14 Strength of metal terminal Termination not to be broken or loosened. A static load of 10N using ig should be applied to the center in the direction of the arrow and held be applied to the center in the direction of the arrow and held be applied to the center in the direction of the arrow and held be applied to the center in the direction of the arrow and held be applied to the center in the direction of the arrow and held be applied to the center in the direction of the arrow and held be applied to the center in the direction of the applied to the direction of the arrow and held be applied to the direction of the appendix and the following tat the followin					of test method".
14 Strength of metal terminal Termination not to be broken or loosened. A static load of lon using a pressure lig should be applied to the center in the direction of the draw and held for 10 s. Pressure lig should be applied to the center in the direction of the draw and held for 10 s. 15 Temperature cycle Appearance No marking defects. Fix the capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". 15 Temperature cycle D.F. Pass the item No.7. Perform the 100 cycles according to the 4 heat treatments listed in the following tat 4 heat reatments listed in the following tat 2 no 3. 16 Humidity Appearance No marking defects. Sit the capacitor at 40±2"C and relative for 64±2 h at room condition*. 16 Humidity Appearance No marking defects. Sit the capacitor at 40±2"C and relative humidity 90 to 95% for 500±24/-0 h. 16 Humidity Appearance No marking defects. Sit the capacitor at 40±2"C and relative humidity. 16 Humidity Appearance No marking defects. Sit the capacitor at 40±2"C and relative humidity. 16 Humidity Appearance No marking defects. Sit the capacitor at 40±2"C and relative humidity.45 to 75%, Atm					
Interstant and the second					
15 Temperature cycle Appearance D.F. No marking defects. Fix the capacitor to the supporting Test Jig (glass epoxy board) shown in "Compleme of test method". 15 Temperature cycle Appearance D.F. No marking defects. Fix the capacitor to the supporting Test Jig (glass epoxy board) shown in "Compleme of test method". 15 Temperature cycle Appearance D.F. Pass the item No.7. Perform the 100 cycles according to the 4 heat treatments listed in the following tat the following tat 2 m Room Temp. 2 to 3 3 to 3 3 to 3 3 to 3 4 to 2 complements 16 Humidity Appearance D.F. No marking defects. Firetreatment Pass the item No.4. 16 Humidity Appearance D.F. No marking defects. Sit the capacitor at 4D-2*C and relative humidity 90 to 95% for 500+24/-0 h. Remove and let sit for 24±2 h at room condition*, then measure. 16 Humidity Appearance Capaciance Change No marking defects. Sit the capacitor at 4D-2*C and relative humidity 90 to 95% for 500+24/-0 h. Remove and let sit for 24±2 h at room condition*. 16 Humidity Appearance Capaciance Change No marking defects. Sit the capacitor at 4D-2*C and relative humidity 90 to 95% for 500+24/-0 h. Remove and let sit for 24±2 h at room condition*. 17. I.R. 12.5 MQ-µF or more D.F. Perform the heat treatment at 150+0/-10°C for 604-5 min and then let sit for 2	14	Strength of metal te	erminal		
15 Temperature cycle Appearance No marking defects. Fix the capacitor to the supporting Test Jig (alses epoxy board) shown in "Complement of test method". 15 Temperature cycle Appearance No marking defects. Fix the capacitor to the supporting Test Jig (alses epoxy board) shown in "Complement of test method". 16 Temperature cycle Appearance No marking defects. Fix the capacitor to the supporting Test Jig (alses epoxy board) shown in "Complement of test method". 17. Pass the item No.5. 4 heat treatments listed in the following tat the following tag tag tag tag tag tag tag tag tag ta				loosenea.	or row using Pressure
15 Temperature cycle Appearance No marking defects. Fix the capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". 15 Temperature cycle Appearance No marking defects. Fix the capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". 16 D.F. Pass the item No.5. 4 heat treatments listed in the following tat the iter of test method". 17 I.R. Pass the item No.5. 4 heat treatments listed in the following tat the iter of test method". 18 Pass the item No.4. Step Temp. (°C) Time (mit 1 Min. Operating Temp.±3 30±3) 2 2 Room Temp. 2 to 3 4 Room Temp. 2 to 3 19 Appearance No marking defects. Sit the capacitor at 40±2°C and relative neesure. *Pretreatment 16 Humidity Appearance No marking defects. Sit the capacitor at 40±2°C and relative numidity 90 to 95% for 500±40.0 h. Remove and let sit for 24±2 h at room condition". 16 Humidity Appearance No marking defects. Sit the capacitor at 40±2°C and relative numidity 90 to 95% for 500±40.0 h. 16 Humidity D.F. 0.2 max. - - 17.8. 12.5 Mt2.0 µ or more					
15 Temperature cycle Appearance No marking defects. Capacitance change Fix the capacitance to the supporting Test Jig (Jass epoxy board) shown in "Complement of test method". 15 Temperature cycle Appearance No marking defects. Capacitance change Fix the capacitance not the supporting Test Jig (Jass epoxy board) shown in "Complement of test method". 16 I.R. Pass the item No.4. Step Temp. (*C) Time (min 1) 1 Min. Operating Temp.±3 30±3 30±3 2 Room Temp. 2 to 3 3 2 Room Temp. 2 to 3 4 Room Temp. 2 to 3 4 Room Temp. 2 to 3 4 Room Temp. 2 to 3 4 Room Temp. 2 to 3 4 Room Temp. 2 to 3 4 Room Temp. 2 to 3 4 Room Temp. 2 to 3 4 Room Temp. 2 to 3 4 Room Temp. 2 to 3 4 Room Temp. 2 to 3 4 Room Temp. 2 to 3 4 Room Temp. 2 to 3 4 Room Temp. 2 to 3 4 Room Temp. 2 to 3 4 Room Temp.					In the Road Street Stre
15 Temperature cycle Appearance No marking defects. Fix the capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". 15 Temperature cycle Appearance No marking defects. Fix the capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". 16 D.F. Pass the item No.5. Perform the 100 cycles according to the 4 heat treatments listed in the following tat the foll					
15 Temperature cycle Appearance No marking defects. Fix the capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". 15 Temperature cycle D.F. Pass the item No.7. Perform the 100 cycles according to the 4 heat treatments listed in the following tat the following tat 100 cycles according to the 4 heat treatments listed in the following tat 100 cycles according to the 4 heat treatments listed in the following tat 100 cycles according to the 4 heat treatments listed in the following tat 100 cycles according to the 4 heat treatments listed in the following tat 100 cycles according to the 4 heat treatments listed in the following tat 100 cycles according to the 4 heat treatments listed in the following tat 100 cycles according to the 4 heat treatments listed in the following tat 100 cycles according to the 4 heat treatments listed in the following tat 100 cycles according to the 4 heat treatments listed in the following tat 100 cycles according to the 4 heat treatments listed in the following tat 100 cycles according to the 4 heat treatment at 150+0/-10° cycles according to the 4 heat treatment at 150+0/-10° cycles accordition". 16 Humidity Appearance No marking defects. Sit the capacitor at 40+2°C and relative numidity 90 to 95% for 500+24/-0 h. Remove and let sit for 24+2 h at room condition". 16 Humidity Appearance No marking defects. Sit the capacitor at 40+2°C and relative numidity 90 to 95% for 500+24/-0 h. Remove and let sit for 24+2 h at room condition". 17 I.R. 12.5 MΩ+1F or more Perform the heat treatment at 150+0/-10° cycles theat room condition".					
15 Temperature cycle Appearance No marking defects. Fix the capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". 15 D.F. Pass the item No.7. Perform the 100 cycles according to the 4 heat treatments listed in the following tat the f					
15 Temperature cycle Appearance No marking defects. Fix the capacitor to the supporting Test Jig (glass epoxy board) shown in "Complement of test method". 15 Temperature cycle Dif. Pass the item No.7. Perform the 100 cycles according to the lollowing tat big item the following tat big item the big item tat big item the following tat big item the big item tat bitem tat big item tat bitem tat big item tat bi					
cycle Capacitance change Within ±7.5% (glass epoxy board) shown in "Complement of test method". D.F. Pass the item No.5. Perform the 100 cycles according to the Dielectric strength Pass the item No.4. Step Temp. (*C) 1 Min.Operating Temp.±2 30±3 2 Room Temp. 2 to 3 3 Max.Operating Temp.±2 30±3 4 Room Temp. 2 to 3 3 Max.Operating Temp.±2 30±3 4 Room Temp. 2 to 3 3 Max.Operating Temp.±2 30±3 4 Room Temp. 2 to 3 3 Max.Operating Temp.±2 30±3 4 Room Temp. 2 to 3 3 Max.Operating Temp.±2 30±3 4 Room Temp. 2 to 3 3 Max.Operating Temp.±2 30±3 4 Room Temp. 2 to 3 3 Max.Operating Temp.±2 30±3 4 Room Temp. 2 to 3 5 Max.Operating Temp.et at reatment at 150±0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*. <td< td=""><td></td><td></td><td></td><td></td><td></td></td<>					
cycle Capacitance change Within ±7.5% (glass epoxy board) shown in "Complement of test method". D.F. Pass the item No.5. Perform the 100 cycles according to the Dielectric strength Pass the item No.4. Step Temp. (*C) 1 Min.Operating Temp.±2 30±3 2 Room Temp. 2 to 3 3 Max.Operating Temp.±2 30±3 4 Room Temp. 2 to 3 3 Max.Operating Temp.±2 30±3 4 Room Temp. 2 to 3 3 Max.Operating Temp.±2 30±3 4 Room Temp. 2 to 3 3 Max.Operating Temp.±2 30±3 4 Room Temp. 2 to 3 3 Max.Operating Temp.±2 30±3 4 Room Temp. 2 to 3 3 Max.Operating Temp.±2 30±3 4 Room Temp. 2 to 3 3 Max.Operating Temp.±2 30±3 4 Room Temp. 2 to 3 5 Max.Operating Temp.et at reatment at 150±0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*. <td< td=""><td>15</td><td>Temperature</td><td>Appearance</td><td>No marking defects.</td><td>Fix the capacitor to the supporting Test Jig A</td></td<>	15	Temperature	Appearance	No marking defects.	Fix the capacitor to the supporting Test Jig A
change of test method". D.F. Pass the item No.5. Heard of the term of term of the term of term of term of the term of te				Within ±7.5%	(glass epoxy board) shown in "Complement
D.F. Pass the item No.7. Perform the 100 cycles according to the like item No.5. Dielectric Pass the item No.4. 4 heat treatments listed in the following tat heat treatments is the item No.4. Dielectric Pass the item No.4. Step Temp. (*C) Time (min 1 Min. Operating Temp.±3 30±3 2 Room Temp. 2 to 3 3. 10 Max. Operating Temp.±3 30±3 2 Room Temp. 2 to 3. 11 Min. Operating Temp.±3 30±3 2 Room Temp. 2 to 3. 12 Room Temp. 2 to 3. 14 Room Temp. 2 to 3. 15 Humidity Appearance (Steady state) Appearance No marking defects. 16 Humidity Capacitance Within ±15% Sti the capacitor at 40±2°C and relative humidity 90 to 95% for 500±24/-0 h. (Steady state) D.F. 0.2 max. *Pretreatment 17. Dielectric strength Pass the item No.4. *Pretreatment 18. 12.5 MΩ·µF or more Perform the heat treatment at 150+0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*, then measure. 19. 0.2 max. *Pretreatment 10. Perform the heat treatment at 150+0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*. **room condition*		-			of test method".
Initial construction Pass the item No.4. Step Temp. (*C) Time (min 100:0.1) Image: Strength Pass the item No.4. Step Temp. (*C) Time (min 100:0.1) Image: Strength Pass the item No.4. Image: Strength Step Temp. (*C) Time (min 100:0.1) Image: Strength Pass the item No.4. Image: Strength Step Temp. (*C) Time (min 100:0.1) Image: Strength Pass the item No.4. Image: Strength Step Temp. (*C) Time (min 100:0.1) Image: Strength Appearance No marking defects. Step Temp. (*C) Time (min 100:0.1) Image: Strength Appearance No marking defects. Step Step reteatment at 150+0/-10°C for 60:5 min and then let sit for 24:2 h at room condition*, then measure. Perform the heat treatment at 150+0/-10°C for 60:5 min and let sit for 24:2 h at room condition*, then measure. I.F. 0.2 max. Perform the heat treatment at 150+0/-10°C for 60:5 min and then let sit for 24:2 h at room condition*, then measure. Perform the heat treatment at 150+0/-10°C for 60:5 min and then let sit for 24:2 h at room condition*. * "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa			D.F.	Pass the item No.7.	Perform the 100 cycles according to the
strength 1 Min. Operating Temp.±3 30±3 2 Room Temp. 2 to 3 3 Max. Operating Temp.±2 30±3 4 Room Temp. 2 to 3 Let sit for 24±2 h at room condition*, then measure. •Pretreatment •Pretreatment Sit the capacitor at 40±2°C and relative humidity 90 to 95% for 500±4/-0 h. (Steady state) Appearance No marking defects. D.F. 0.2 max. Sit the capacitor at 40±2°C and relative humidity 90 to 95% for 500±4/-0 h. Remove and let sit for 24±2 h at room condition*, then measure. •Pretreatment I.R. 12.5 MΩ·µF or more Perform the heat treatment at 150±0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*. *"room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa *"room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa <td></td> <td></td> <td>I.R.</td> <td>Pass the item No.5.</td> <td>4 heat treatments listed in the following table</td>			I.R.	Pass the item No.5.	4 heat treatments listed in the following table
Image: Properties of the state of the			Dielectric	Pass the item No.4.	Step Temp. (°C) Time (min)
Image: Properties of the state of the			strength		1 Min. Operating Temp.±3 30±3
4 Room Temp. 2 to 3 Let sit for 24±2 h at room condition*, then measure. •Pretreatment •Pretreatment •Pretreatment 16 Humidity (Steady state) Appearance No marking defects. 5 Sit the capacitor at 40±2°C and relative change Within ±15% D.F. 0.2 max. *Pretreatment 1.R. 12.5 MΩ·µF or more *Pretreatment Dielectric strength Pass the item No.4. *Pretreatment at 150+0/-10°C * "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa			-		2 Room Temp. 2 to 3
Image: Appearance No marking defects. Sit the capacitor at 40±2°C and relative for 60±5 min and then let sit for 24±2 h at room condition*. I6 Humidity (Steady state) Appearance No marking defects. Sit the capacitor at 40±2°C and relative for 60±5 min and then let sit for 24±2 h at room condition*. I6 Humidity (Steady state) Appearance No marking defects. Sit the capacitor at 40±2°C and relative for 60±5 min and then let sit for 24±2 h at room condition*, then measure. I.R. 12.5 MΩ:µF or more Perform the heat treatment at 150+0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*, then measure. I.R. 12.5 MΩ:µF or more Perform the heat treatment at 150+0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*. * "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa					3 Max. Operating Temp.±2 30±3
I6 Humidity (Steady state) Appearance No marking defects. Sit the capacitor at 40±2°C and relative norm condition*. I6 Humidity (Steady state) Appearance No marking defects. Sit the capacitor at 40±2°C and relative humidity 90 to 95% for 500+24/-0 h. Remove and let sit for 24±2 h at room condition*, then measure. I.R. 12.5 MΩ·µF or more Pretreatment D.F. 0.2 max. Pretreatment I.R. 12.5 MΩ·µF or more Pretreatment Dielectric strength Pass the item No.4. Perform the heat treatment at 150+0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*. * "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa					4 Room Temp. 2 to 3
I6 Humidity (Steady state) Appearance No marking defects. Sit the capacitor at 40±2°C and relative norm condition*. I6 Humidity (Steady state) Appearance No marking defects. Sit the capacitor at 40±2°C and relative humidity 90 to 95% for 500+24/-0 h. Remove and let sit for 24±2 h at room condition*, then measure. I.R. 12.5 MΩ·µF or more Pretreatment D.F. 0.2 max. Pretreatment I.R. 12.5 MΩ·µF or more Pretreatment Dielectric strength Pass the item No.4. Perform the heat treatment at 150+0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*. * "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa					Let sit for 24+2 h at room condition* then
Image: Pretreatment Pretreatment Perform the heat treatment at 150+0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*. I6 Humidity (Steady state) I6 Humidity (Steady state) I6 Humidity (Steady state) I7 D.P. I7 0.2 max. I7 D.P. I7 0.2 max. I7 I7. I7. 12.5 MΩ·μF or more Dielectric strength Pass the item No.4. * "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa					
Image: Perform the heat treatment at 150+0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*. I6 Humidity (Steady state) Appearance No marking defects. Sit the capacitor at 40±2°C and relative humidity 90 to 95% for 500+24/-0 h. Remove and let sit for 24±2 h at room condition*, then measure. I.R. 12.5 MΩ·µF or more •Perform the heat treatment at 150+0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*, then measure. * "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa					
16 Humidity (Steady state) Appearance No marking defects. Sit the capacitor at 40±2°C and relative humidity 90 to 95% for 500+24/-0 h. Remove and let sit for 24±2 h at room condition*, then measure. 17. 0.2 max. •Pretreatment Dielectric strength •Pretreatment Pass the item No.4. * "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa					Perform the heat treatment at 150+0/-10°C
16 Humidity (Steady state) Appearance No marking defects. Sit the capacitor at 40±2°C and relative humidity 90 to 95% for 500+24/-0 h. Remove and let sit for 24±2 h at room condition*, then measure. D.F. 0.2 max. Pretreatment Dielectric strength Pass the item No.4. Pretreatment to 24±2 h at room condition*. * "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa					
(Steady state) Capacitance change Within ±15% humidity 90 to 95% for 500+24/-0 h. Remove and let sit for 24±2 h at room condition*, then measure. D.F. 0.2 max. order the change Perform the heat treatment at 150+0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*. Within ±15% Pass the item No.4. Perform the heat treatment at 150+0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*. * "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa					
change D.F. 0.2 max. condition*, then measure. I.R. 12.5 MΩ·μF or more •Pretreatment Dielectric strength Pass the item No.4. •Pretreatment the heat treatment at 150+0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*. * "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa	16	Humidity		No marking defects.	Sit the capacitor at 40±2°C and relative
D.F. 0.2 max. condition*, then measure. I.R. 12.5 MΩ·μF or more Pretreatment Dielectric strength Pass the item No.4. Perform the heat treatment at 150+0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*. * "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa		(Steady state)		Within ±15%	humidity 90 to 95% for 500+24/-0 h.
D.F. 0.2 max. condition*, then measure. I.R. 12.5 MΩ·μF or more Pretreatment Dielectric strength Pass the item No.4. Perform the heat treatment at 150+0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*. * "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa			change		Remove and let sit for 24±2 h at room
I.R. 12.5 MΩ·μF or more •Pretreatment Dielectric strength Pass the item No.4. Perform the heat treatment at 150+0/-10°C for 60±5 min and then let sit for 24±2 h at room condition*. * "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa			D.F.		
Dielectric strength Pass the item No.4. Perform the near treatment at 150+0/-10 C for 60±5 min and then let sit for 24±2 h at room condition*. * "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa			I.R.		
* "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa			Dielectric		
* "room condition" Temperature:15 to 35°C, Relative humidity:45 to 75%, Atmosphere pressure:86 to 106kPa				-	
	*"		-		
SKRM2101	* "r	com condition" lei	mperature:151	to 35°C, Relative humidity:45 to 75%	%, Atmosphere pressure:86 to 106kPa
SKRM2101					
		DM0104			
	SK	RIVIZIUT			

Reference only

0.	14	0	Specifications	Toot method
	Iten		Specifications	Test method
7	Life	Appearance	No marking defects.	Apply voltage as in the table for 1000+48/- at maximum operating temperature±3°C. Remove and let sit for 24±2 h at room
		Capacitance	Within ±15%	at maximum operating temperature+3°C
		change	1	Remove and let sit for 24+2 h at room
		change		
		D.F.	0.2 max.	condition*, then measure.
		I.R.	25 MΩ· μ F or more	Rated Voltage Applied Voltage
		Dielectric	Pass the item No.4.	
				DC16V, DC25V 150% of the rated voltage
		strength		The charge/discharge current is less than
				50mA.
				 Pretreatment
				Apply test voltage for 60±5 min at test
				temperature
* "го	oom condition" T	emperature:15	to 35°C, Relative humidity:45	to 75%, Atmosphere pressure:86 to 106kPa



ESKRM2101



- (6) The top tape or cover tape and base tape are not attached at the end of the tape for a minimum of 5 pitches.
- (7) Missing capacitors number within 0.1% of the number per reel or 1pc, whichever is greater, and not continuous
- (8) The top tape or cover tape and bottom tape should not protrude beyond the edges of the tape and should not cover sprocket holes.
- (9) Cumulative tolerance of sprocket holes, 10 pitches : ±0.3mm.
- (10) Peeling off force : 0.1 to 0.6N in the direction shown on the follows.

165 to 180° Top Tape or Cover Tape \leq V -Base Tape

EU RoHS

This products of the following crresponds to EU RoHS.

RoHS

maximum concentration values tolerated by weight in homogeneous materials

- •1000 ppm maximum Lead
- •1000 ppm maximum Mercury
- •100 ppm maximum Cadmium
- •1000 ppm maximum Hexavalent chromium
- •1000 ppm maximum Polybrominated biphenyls (PBB)
- •1000 ppm maximum Polybrominated diphenyl ethers (PBDE)

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for Multilayer Ceramic Capacitors MLCC - SMD/SMT category:

Click to view products by Murata manufacturer:

Other Similar products are found below :

D55342E07B523DR-T/R NCA1206X7R104K16TRPF NIN-FB391JTRF NIN-FC2R7JTRF NMC0402NPO220J50TRPF NMC0402X5R105K6.3TRPF NMC0402X5R224K6.3TRPF NMC0402X7R103J25TRPF NMC0402X7R153K16TRPF NMC0402X7R392K50TRPF NMC0603NPO1R8C50TRPF NMC0603NPO20JJ50TRPF NMC0603NPO330G50TRPF NMC0603X5R475M6.3TRPF NMC0805NPO220J100TRPF NMC0805NPO270J50TRPF NMC0805NPO681F50TRPF NMC0805NPO820J50TRPF NMC1206X7R102K50TRPF NMC1210Y5V105Z50TRPLPF NMC-L0402NPO7R0C50TRPF NMC-L0603NPO2R2B50TRPF NMC-P0805NPO221J500TRPLPF NMC-P1206X7R103K1KVTRPLPF NMC-Q0402NPO8R2D200TRPF C1206C101J1GAC C1608C0G2A221J C1608X7R1E334K C2012C0G2A472J 2220J2K00562KXT KHC201E225M76N0T00 1812J2K00332KXT CCR06CG153FSV CDR14BP471CJUR CDR31BX103AKWR CDR33BX683AKUS CGA2B2C0G1H010C CGA2B2C0G1H040C CGA2B2C0G1H050C CGA2B2C0G1H060D CGA2B2C0G1H070D CGA2B2C0G1H120J CGA2B2C0G1H151J CGA2B2C0G1H1R5C CGA2B2C0G1H2R2C CGA2B2C0G1H390J CGA2B2C0G1H391J CGA2B2C0G1H3R3C CGA2B2C0G1H680J CGA2B2C0G1H6R8D